

www.din-tek.jp

1200V N-Channel Silicon Carbide Power MOSFET

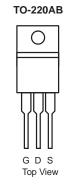
Features

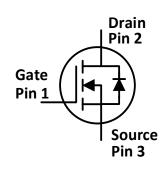
- High blocking voltage
- High speed switching with low capacitance
- High operating junction temperature capability
- Very fast and robust intrinsic body diode

Applications

- Solar inverters
- UPS
- High voltage DC/DC converters
- Switch mode power supplies

Package





Part Number	Package		
DTP6N120SC	TO220-3		

Absolute Maximum Ratings (T_c=25°C unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note	
V _{DS}	Drain-Source Voltage	1200	V	V _{GS} =0V, I _D =10μA		
V _{GSmax} (DC)	Maximum Gate-Source Voltage (DC)	-5 to 22	V	Static (DC)		
V _{GSmax}	Maximum Gate-Source Voltage	-10 to 25	V	Duty cycle<1%		
(Spike)	(Spike)	-10 to 25	V	Pulse width<200ns		
V _{GS(on)}	Recommended Turn-on Voltage	20±0.5	V			
V _{GS(off)}	Recommended Turn-off Voltage	-3.5 to -2	V			
1	Drain Current (Continuous)	6.4	А	V _{GS} =20V, T _C =25°C	Fig. 21	
I _D	Diani Current (Continuous)	4.9	А	V _{GS} =20V, T _C =100°C	Fig. 21	
Ірм	Drain Current (Pulsed)	12.8	А	Pulse width limited by SOA	Fig. 24	
P _{TOT}	Total Power Dissipation	66.9	W	T _c =25°C	Fig. 22	
T _{stg}	Storage Temperature Range	-55 to 175	°C			
Tı	Operating Junction Temperature	-55 to 175	°C			
Tı	Solder Temperature	260	°C	Wave soldering only allowed at leads, 1.6mm from case for 10 s		

Thermal Data

Symbol	Parameter	Value	Unit	Note
$R_{\theta(J-C)}$	Thermal Resistance from Junction to Case	2.24	°C/W	Fig. 23

1



www.din-tek.jp

Electrical Characteristics (T_c=25°C unless otherwise specified)

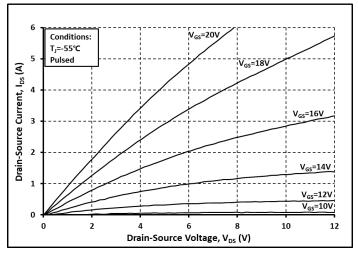
Symbol	Parameter		Value		Unit	Test Conditions	Note
		Min.	Тур.	Max.			
loss	Drain Leakage Current (Zero Gate Voltage)		0.1	10	μΑ	V _{DS} =1200V, V _{GS} =0V	
I _{GSS}	Gate Leakage Current		1	±100	nA	V _{DS} =0V, V _{GS} =-5~20V	
			4.3		V	V _{GS} =V _{DS} , I _D =380μA	
V_{th}	Gate Threshold Voltage		3.3		V	V _{GS} =V _{DS} , I _D =380μA @ T _C =175°C	Fig. 9
	Static Drain-Source		750	900	mΩ	V _{GS} =20V, I _D =1.5A @T _J =25°C	Fig. 4, 5,
Ron	On-resistance		1070		mΩ	V _{GS} =20V, I _D =1.5A @T _J =175°C	6, 7
Ciss	Input Capacitance		260		рF		
C_{oss}	Output Capacitance		15		рF	V _{DS} =800V, V _{GS} =0V,	Fig. 16
Crss	Reverse Transfer Capacitance		2.6		рF	f=1MHz, V _{AC} =25mV	119. 10
Eoss	Coss Stored Energy		5.8		μЈ	_	Fig. 17
Q _G	Total Gate Charge		15.8		nC	\/ -000\/ L -1 FA	
Q _{GS}	Gate-Source Charge		3.3		nC	V_{DS} =800V, I_{D} =1.5A, V_{GS} =-5 to 20V	Fig. 18
Q _{GD}	Gate-Drain Charge		11.6		nC	VGS—-3 tO 20V	
R _G	Gate Input Resistance		26.8		Ω	f=1MHz	
Eon	Turn-on Switching Energy		24		μЈ		
E _{off}	Turn-off Switching Energy		4.1		μЈ	V _{DS} =800V, I _D =1.5A,	
t _{d(on)}	Turn-on Delay Time		8.5			V_{GS} = -3.5V to 20V,	Fig. 19,
tr	Rise Time		9.6		ns	$R_{G(ext)}=0\Omega$,	20
t _{d(off)}	Turn-off Delay Time		12.4		113	L=1550μH	
t _f	Fall Time		34.8				

Reverse Diode Characteristics (T_c=25°C unless otherwise specified)

Symbol	Parameter	Value			Unit	Test Conditions	Note
		Min.	Тур.	Max.			
			4.1		V	I _{SD} =1.5A, V _{GS} =0V	Fig. 11
V_{SD}	Diode Forward Voltage		3.6	V	I _{SD} =1.5A, V _{GS} =0V,	Fig. 11, 12	
					V	@ T ₁ =175°C	12
t _{rr}	Reverse Recovery Time		59		ns	$V_{GS} = -3.5V/+20V$,	
Qrr	Reverse Recovery Charge		26		nC	I _{SD} =1.5A, V _R =800V,	
ı	Peak Reverse Recovery		1 2		А	di/dt=276A/μs,	
I _{RRM}	Current		1.3			$R_{G(ext)}=82\Omega$	



Typical Performance (curves)



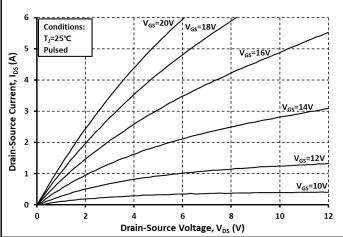
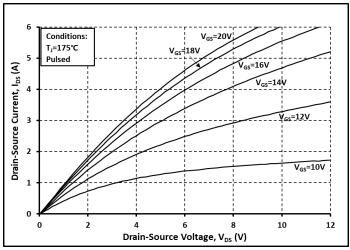


Fig. 1 Output Curve @ T₁=-55°C

Fig. 2 Output Curve @ T₁=25°C



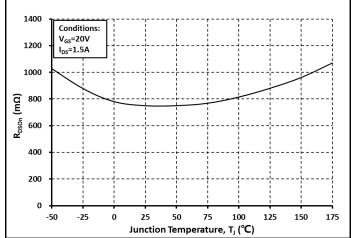
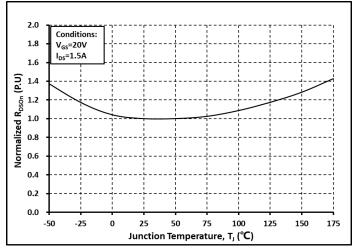


Fig. 3 Output Curve @ T₁=175°C

Fig. 4 Ron vs. Temperature



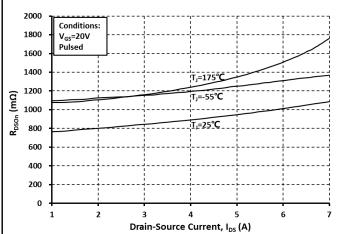
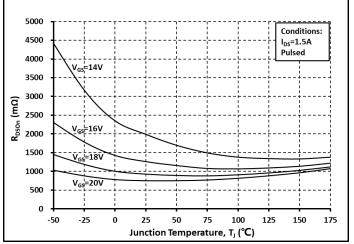


Fig. 5 Normalized Ron vs. Temperature

Fig. 6 Ron vs. I_{DS} @ Various Temperature





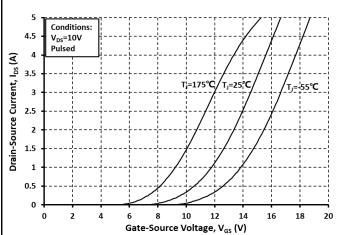
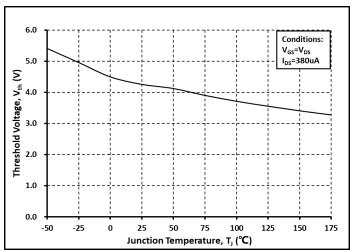


Fig. 7 Ron vs. Temperature @ Various V_{GS}

Fig. 8 Transfer Curves @ Various Temperature



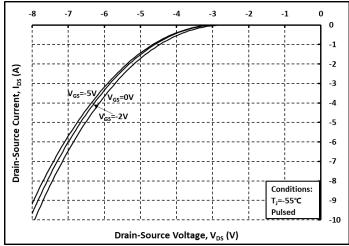
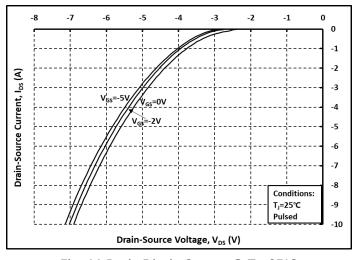


Fig. 9 Threshold Voltage vs. Temperature

Fig. 10 Body Diode Curves @ T₁=-55°C



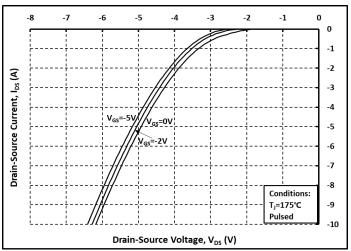
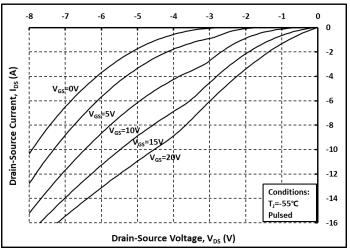


Fig. 11 Body Diode Curves @ T₁=25°C

Fig. 12 Body Diode Curves @ T₁=175°C





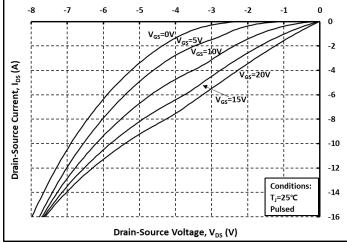
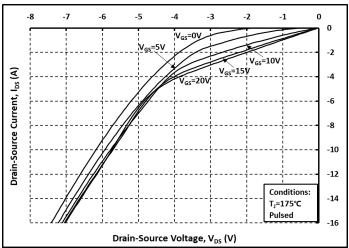


Fig. 13 3rd Quadrant Curves @ T₁=-55°C

Fig. 14 3rd Quadrant Curves @ T_J=25°C



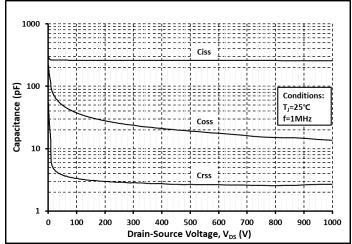
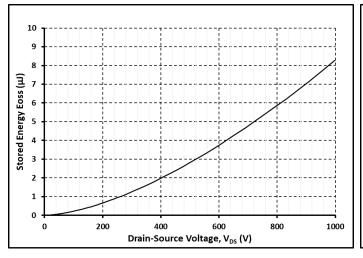


Fig. 15 3rd Quadrant Curves @ T_J=175°C

Fig. 16 Capacitance vs. V_{DS}



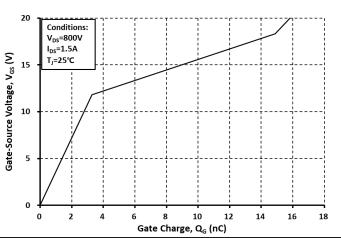
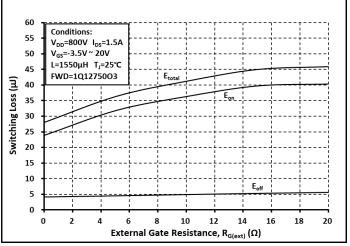


Fig. 17 Output Capacitor Stored Energy

Fig. 18 Gate Charge Characteristics





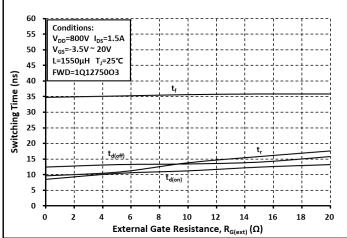
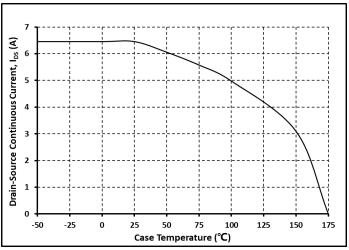


Fig. 19 Switching Energy vs. R_{G(ext)}

Fig. 20 Switching Time vs. R_{G(ext)}



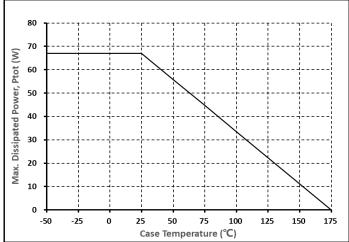
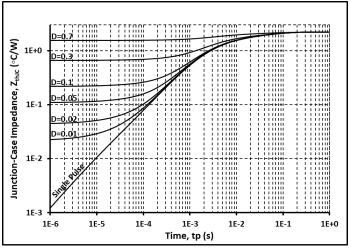


Fig. 21 Continuous IDS vs. Tc

Fig. 22 Max. Power Dissipation Derating vs. Tc



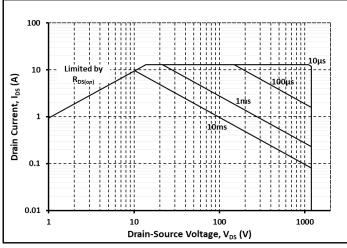
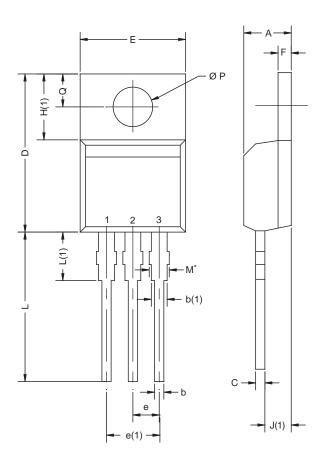


Fig. 23 Thermal Impedance

Fig. 24 Safe Operating Area







	MILLIN	/IETERS	INCHES			
DIM.	MIN.	MAX.	MIN.	MAX.		
Α	4.25	4.65	0.167	0.183		
b	0.69	1.01	0.027	0.040		
b(1)	1.20	1.73	0.047	0.068		
С	0.36	0.61	0.014	0.024		
D	14.85	15.49	0.585	0.610		
Е	10.04	10.51	0.395	0.414		
е	2.41	2.67	0.095	0.105		
e(1)	4.88	5.28	0.192	0.208		
F	1.14	1.40	0.045	0.055		
H(1)	6.09	6.48	0.240	0.255		
J(1)	2.41	2.92	0.095	0.115		
L	13.35	14.02	0.526	0.552		
L(1)	3.32	3.82	0.131	0.150		
ØР	3.54	3.94	0.139	0.155		
Q	2.60	3.00	0.102	0.118		
ECN: X12- DWG: 547	0208-Rev. N, 1	08-Oct-12				

 $^{^{\}star}$ M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM

www.din-tek.jp

Disclaimer

ALL PRODUCT, PRODUCT SPECIFICATIONS AND DATA ARE SUBJECT TO CHANGE WITHOUT NOTICE TO IMPROVE RELIABILITY, FUNCTION OR DESIGN OR OTHERWISE.

Din-Tek Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Din-Tek"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained in any datasheet or in any other disclosure relating to any product.

Din-Tek makes no warranty, representation or guarantee regarding the suitability of the products for any particular purpose or the continuing production of any product. To the maximum extent permitted by applicable law, Din-Tek disclaims (i) any and all liability arising out of the application or use of any product, (ii) any and all liability, including without limitation special, consequential or incidental damages, and (iii) any and all implied warranties, including warranties of fitness for particular purpose, non-infringement and merchantability.

Statements regarding the suitability of products for certain types of applications are based on Din-Tek's knowledge of typical requirements that are often placed on Din-Tek products in generic applications. Such statements are not binding statements about the suitability of products for a particular application. It is the customer's responsibility to validate that a particular product with the properties described in the product specification is suitable for use in a particular application. Parameters provided in datasheets and/or specifications may vary in different applications and performance may vary over time. All operating parameters, including typical parameters, must be validated for each customer application by the customer's technical experts. Product specifications do not expand or otherwise modify Din-Tek's terms and conditions of purchase, including but not limited to the warranty expressed therein.

Except as expressly indicated in writing, Din-Tek products are not designed for use in medical, life-saving, or life-sustaining applications or for any other application in which the failure of the Din-Tek product could result in personal injury or death. Customers using or selling Din-Tek products not expressly indicated for use in such applications do so at their own risk. Please contact authorized Din-Tek personnel to obtain written terms and conditions regarding products designed for such applications.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Din-Tek. Product names and markings noted herein may be trademarks of their respective owners.

Material Category Policy

Din-Tek Intertechnology, Inc. hereby certifies that all its products that are identified as RoHS-Compliant fulfill the definitions and restrictions defined under Directive 2011/65/EU of The European Parliament and of the Council of June 8, 2011 on the restriction of the use of certain hazardous substances in electrical and electronic equipment (EEE) - recast, unless otherwise specified as non-compliant.

Please note that some Din-Tek documentation may still make reference to RoHS Directive 2002/95/EC. We confirm that all the products identified as being compliant to Directive 2002/95/EC conform to Directive 2011/65/EU.

Din-Tek Intertechnology, Inc. hereby certifies that all its products that are identified as Halogen-Free follow Halogen-Free requirements as per JEDEC JS709A standards. Please note that some Din-Tek documentation may still make reference to the IEC 61249-2-21 definition. We confirm that all the products identified as being compliant to IEC 61249-2-21 conform to JEDEC JS709A standards.